

**Search Notes**

Application No.

09/800,507

Examiner

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Applicant(s)

ARAKAWA ET AL.

Art Unit

2124

**SEARCHED**

Class	Subclass	Date	Examiner
708	514, 524, 709	8/25/2004	<i>mai</i>
712	222	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Double Patenting Check Data Bases Search (see attached copy)	8/25/2004	<i>mai</i>